

### **CISPR TR 16-4-5**

Edition 1.1 2014-07 CONSOLIDATED VERSION

## TECHNICAL REPORT



INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

Specification for radio disturbance and immunity measuring apparatus and methods –

Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods

INTERNATIONAL ELECTROTECHNICAL COMMISSION

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# **REDLINE VERSION**



INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

Specification for radio disturbance and immunity measuring apparatus and methods –

Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods



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#### INTERNATIONAL ELECTROTECHNICAL COMMISSION

### SPECIFICATION FOR RADIO DISTURBANCE AND IMMUNITY MEASURING APPARATUS AND METHODS –

### Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods

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In this Redline version, a vertical line in the margin shows where the technical content is modified by amendment 1. Additions are in green text, deletions are in strikethrough red text. A separate Final version with all changes accepted is available in this publication. CISPR TR 16-4-5:2006 +AMD1:2014 CSV © IEC 2014 - 5 -

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CISPR 16-4-5, which is a technical report, has been prepared by CISPR subcommittee A: Radio-interference measurements and statistical methods.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the CISPR 16-4 series, published under the general title *Specification for* radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainties, statistics and limit modelling, can be found on the IEC website.

The committee has decided that the contents of the base publication and its amendment will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

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### Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods

### 1 Scope

This part of CISPR 16-4 specifies a method to enable product committees to develop limits for alternative test methods, using conversions from established limits. This method is generally applicable for all kinds of disturbance measurements, but focuses on radiated disturbance measurements (i.e. field strength), for which several alternative methods are presently specified. These limits development methods are intended for use by product committees and other groups responsible for defining emissions limits in situations where it is decided to use alternative test methods and the associated limits in product standards.

### 2 Normative references

IEC 60050-161:1990, International Electrotechnical Vocabulary (IEV) – Chapter 161: Electromagnetic compatibility

CISPR 16-4-1<del>:2003</del>, Specification for radio disturbance and immunity measuring apparatus and methods – Part 4-1: Uncertainties, statistics and limit modelling – Uncertainty in standardized EMC tests

CISPR 16-4-2:2003, Specification for radio disturbance and immunity measuring apparatus and methods – Part 4-2: Uncertainties, statistics and limit modelling – Uncertainty in EMC measurements



## **CISPR TR 16-4-5**

Edition 1.1 2014-07 CONSOLIDATED VERSION

# **FINAL VERSION**



INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

Specification for radio disturbance and immunity measuring apparatus and methods –

Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods



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